Application/Control No. Applicant(s)/Patent Under Reexamination 09/542,473 IKEDA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2826 A. Sefer **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 257/344 US-6,399,988 06-2002 Yamazaki, Shunpei Α В US-С US-US-D US-Ε US-F US-G US-Н 1 US-US-J US-Κ US-US-FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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